

ERRATA

N° 10391AERRA

Dear customer,

With this Infineon Technologies AG errata note we would like to inform you about the following

Erratum of Product Marking in Datasheet for BSC094N06LS5

Infineon Technologies AG

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ERRATA

N° 10391AERRA

► Products affected

Please refer to attached affected product list
"ERR_10391AERRA_[customer-no].pdf"

► Detailed change information

Subject	Erratum of Product Marking in Datasheet for BSC094N06LS5	
Reason	Product marking in datasheet shows nonconformance compared to the physical product marking on the device	
Description	<u>Old</u>	<u>New</u>
Marking Text	■ 094N06L	■ 094N06LS

► Impact of change

NO change of existing datasheet parameters
NO change in quality and reliability
NO change in package outline dimensions

► Attachments

ERR_10391AERRA_[customer-no].pdf affected product list
DS_BSC094N06LS5_2_2.pdf Product datasheet

► Implementation date

Immediate

If you have any questions, please do not hesitate to contact your local sales office.

ERR 10391AERRA

Erratum of Product Marking in Datasheet for BSC094N06LS5



Affected products sold to FUTURE ELECTRONICS INC. (4048203)

Sales name	SP number	OPN	Package	Customer part number
BSC094N06LS5	SP001458086	BSC094N06LS5ATMA1	PG-TDSON-8	BSC094N06LS5ATMA1

MOSFET

OptiMOS™ Power-Transistor, 60 V

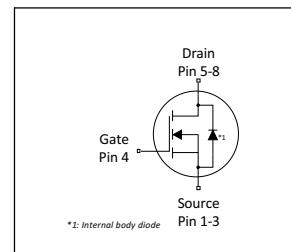
Features

- Optimized for high performance SMPS, e.g. sync. rec.
- 100% avalanche tested
- Superior thermal resistance
- N-channel, logic level
- Qualified according to JEDEC¹⁾ for target applications
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21



Table 1 Key Performance Parameters

Parameter	Value	Unit
V_{DS}	60	V
$R_{DS(on),max}$	9.4	$\text{m}\Omega$
I_D	47	A
Q_{OSS}	13	nC
$Q_G(0V..4.5V)$	7	nC



Type / Ordering Code	Package	Marking	Related Links
BSC094N06LS5	PG-TDSON-8	094N06LS	-

¹⁾ J-STD20 and JESD22

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1 Maximum ratings

at $T_A=25$ °C, unless otherwise specified

Table 2 Maximum ratings

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Continuous drain current	I_D	-	-	47	A	$V_{GS}=10$ V, $T_C=25$ °C
		-	-	30		$V_{GS}=10$ V, $T_C=100$ °C
		-	-	11		$V_{GS}=10$ V, $T_A=25$ °C, $R_{thJA}=50$ K/W ¹⁾
Pulsed drain current ²⁾	$I_{D,pulse}$	-	-	188	A	$T_C=25$ °C
Avalanche energy, single pulse ³⁾	E_{AS}	-	-	13	mJ	$I_D=30$ A, $R_{GS}=25$ Ω
Gate source voltage	V_{GS}	-20	-	20	V	-
Power dissipation	P_{tot}	-	-	36	W	$T_C=25$ °C
		-	-	2.1		$T_A=25$ °C, $R_{thJA}=50$ K/W ¹⁾
Operating and storage temperature	T_J, T_{stg}	-55	-	150	°C	IEC climatic category; DIN IEC 68-1: 55/150/56

2 Thermal characteristics

Table 3 Thermal characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case, bottom	R_{thJC}	-	2.1	3.5	K/W	-
Device on PCB, 6 cm ² cooling area ¹⁾	R_{thJA}	-	-	50	K/W	-

¹⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

²⁾ See Diagram 3 for more detailed information

³⁾ See Diagram 13 for more detailed information

3 Electrical characteristics

Table 4 Static characteristics

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	60	-	-	V	$V_{GS}=0$ V, $I_D=1$ mA
Gate threshold voltage	$V_{GS(th)}$	1.1	1.7	2.3	V	$V_{DS}=V_{GS}$, $I_D=14$ μ A
Zero gate voltage drain current	I_{DSS}	-	0.1 10	1 100	μ A	$V_{DS}=60$ V, $V_{GS}=0$ V, $T_j=25$ °C $V_{DS}=60$ V, $V_{GS}=0$ V, $T_j=125$ °C
Gate-source leakage current	I_{GSS}	-	10	100	nA	$V_{GS}=20$ V, $V_{DS}=0$ V
Drain-source on-state resistance	$R_{DS(on)}$	-	7.7 11	9.4 13.4	$m\Omega$	$V_{GS}=10$ V, $I_D=24$ A $V_{GS}=4.5$ V, $I_D=12$ A
Gate resistance ¹⁾	R_G	-	1.1	1.65	Ω	-
Transconductance	g_{fs}	22	45	-	S	$ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=24$ A

Table 5 Dynamic characteristics¹⁾

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Input capacitance	C_{iss}	-	970	1300	pF	$V_{GS}=0$ V, $V_{DS}=30$ V, $f=1$ MHz
Output capacitance	C_{oss}	-	210	280	pF	$V_{GS}=0$ V, $V_{DS}=30$ V, $f=1$ MHz
Reverse transfer capacitance	C_{rss}	-	12	21	pF	$V_{GS}=0$ V, $V_{DS}=30$ V, $f=1$ MHz
Turn-on delay time	$t_{d(on)}$	-	4	-	ns	$V_{DD}=30$ V, $V_{GS}=10$ V, $I_D=24$ A, $R_{G,ext}=1.6$ Ω
Rise time	t_r	-	3	-	ns	$V_{DD}=30$ V, $V_{GS}=10$ V, $I_D=24$ A, $R_{G,ext}=1.6$ Ω
Turn-off delay time	$t_{d(off)}$	-	14	-	ns	$V_{DD}=30$ V, $V_{GS}=10$ V, $I_D=24$ A, $R_{G,ext}=1.6$ Ω
Fall time	t_f	-	3	-	ns	$V_{DD}=30$ V, $V_{GS}=10$ V, $I_D=24$ A, $R_{G,ext}=1.6$ Ω

Table 6 Gate charge characteristics²⁾

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Gate to source charge	Q_{gs}	-	3	-	nC	$V_{DD}=30$ V, $I_D=24$ A, $V_{GS}=0$ to 4.5 V
Gate charge at threshold	$Q_{g(th)}$	-	2	-	nC	$V_{DD}=30$ V, $I_D=24$ A, $V_{GS}=0$ to 4.5 V
Gate to drain charge ¹⁾	Q_{gd}	-	2	3.5	nC	$V_{DD}=30$ V, $I_D=24$ A, $V_{GS}=0$ to 4.5 V
Switching charge	Q_{sw}	-	4	-	nC	$V_{DD}=30$ V, $I_D=24$ A, $V_{GS}=0$ to 4.5 V
Gate charge total ¹⁾	Q_g	-	7	9.4	nC	$V_{DD}=30$ V, $I_D=24$ A, $V_{GS}=0$ to 4.5 V
Gate plateau voltage	$V_{plateau}$	-	3.1	-	V	$V_{DD}=30$ V, $I_D=24$ A, $V_{GS}=0$ to 4.5 V
Gate charge total, sync. FET	$Q_{g(sync)}$	-	12	-	nC	$V_{DS}=0.1$ V, $V_{GS}=0$ to 10 V
Output charge ¹⁾	Q_{oss}	-	13	18	nC	$V_{DD}=30$ V, $V_{GS}=0$ V

¹⁾ Defined by design. Not subject to production test.

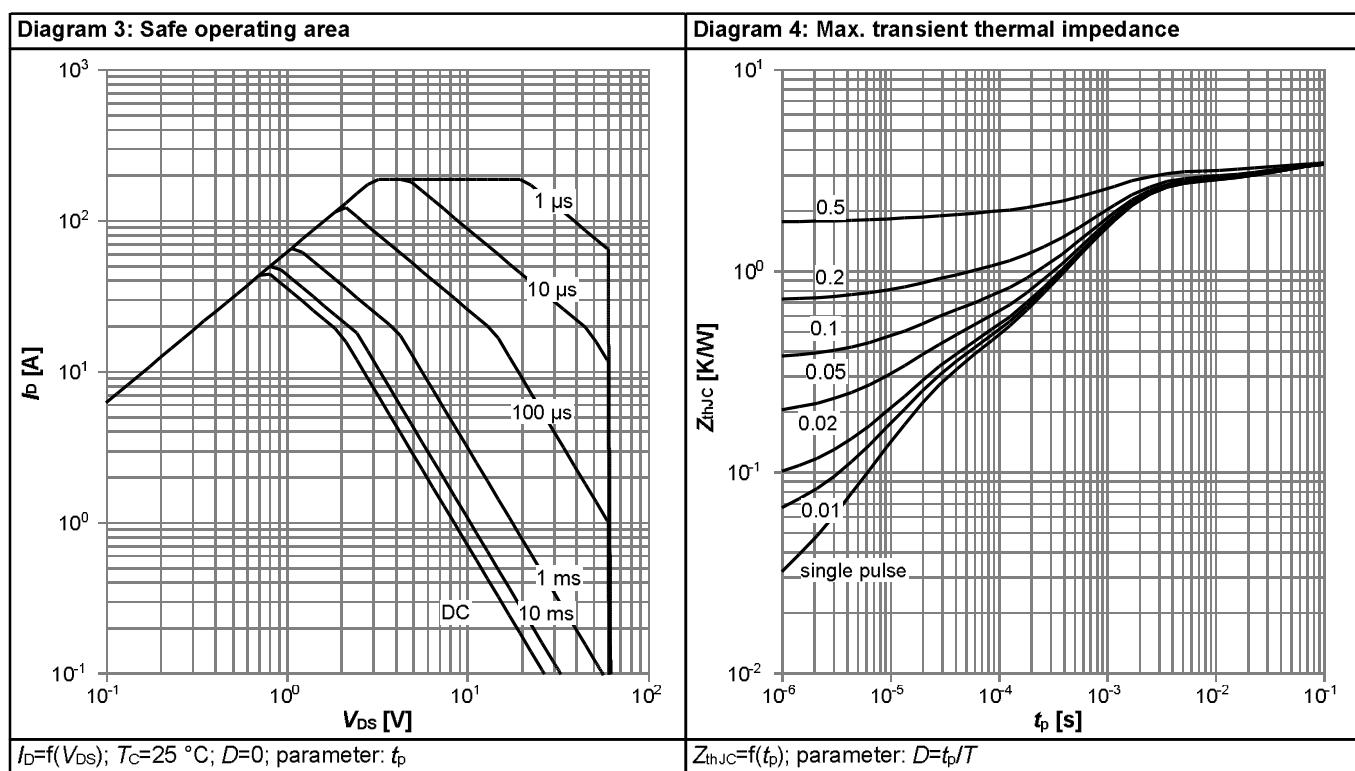
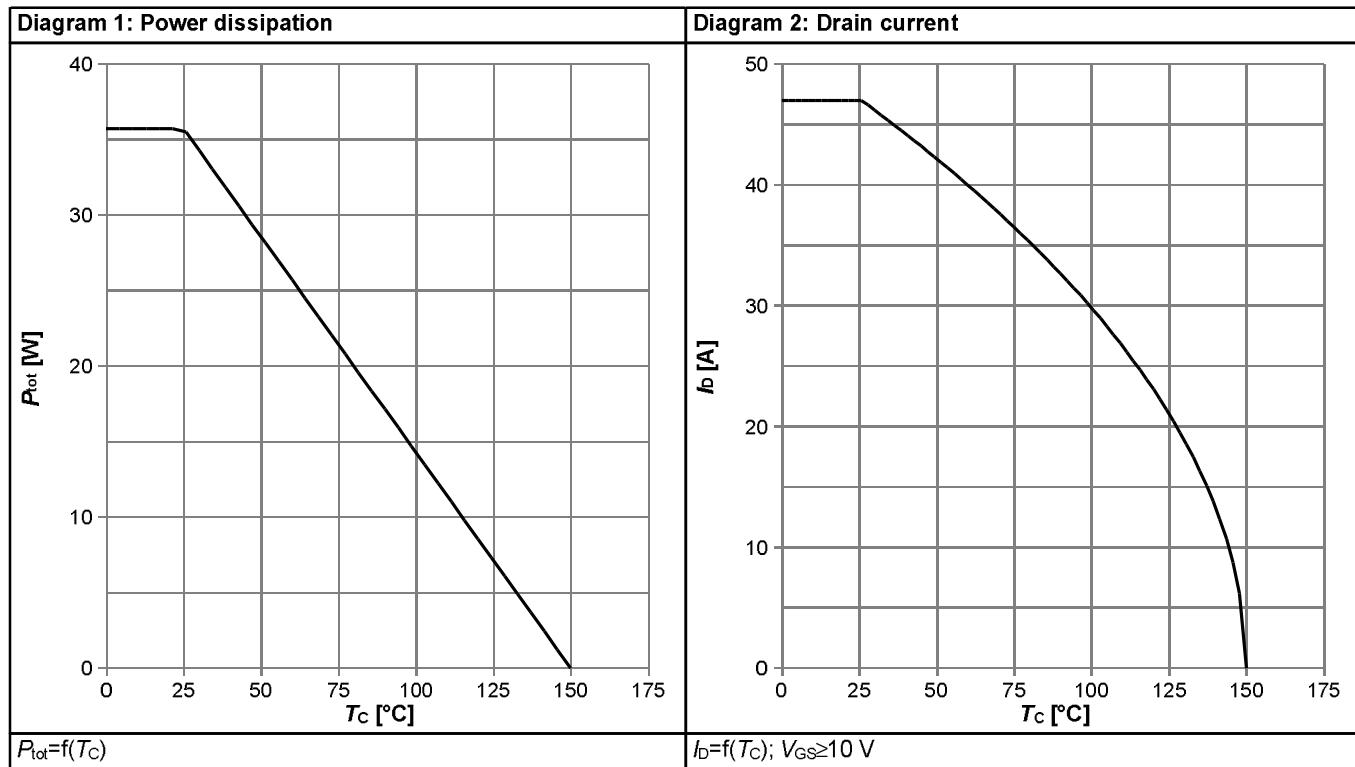
²⁾ See "Gate charge waveforms" for parameter definition

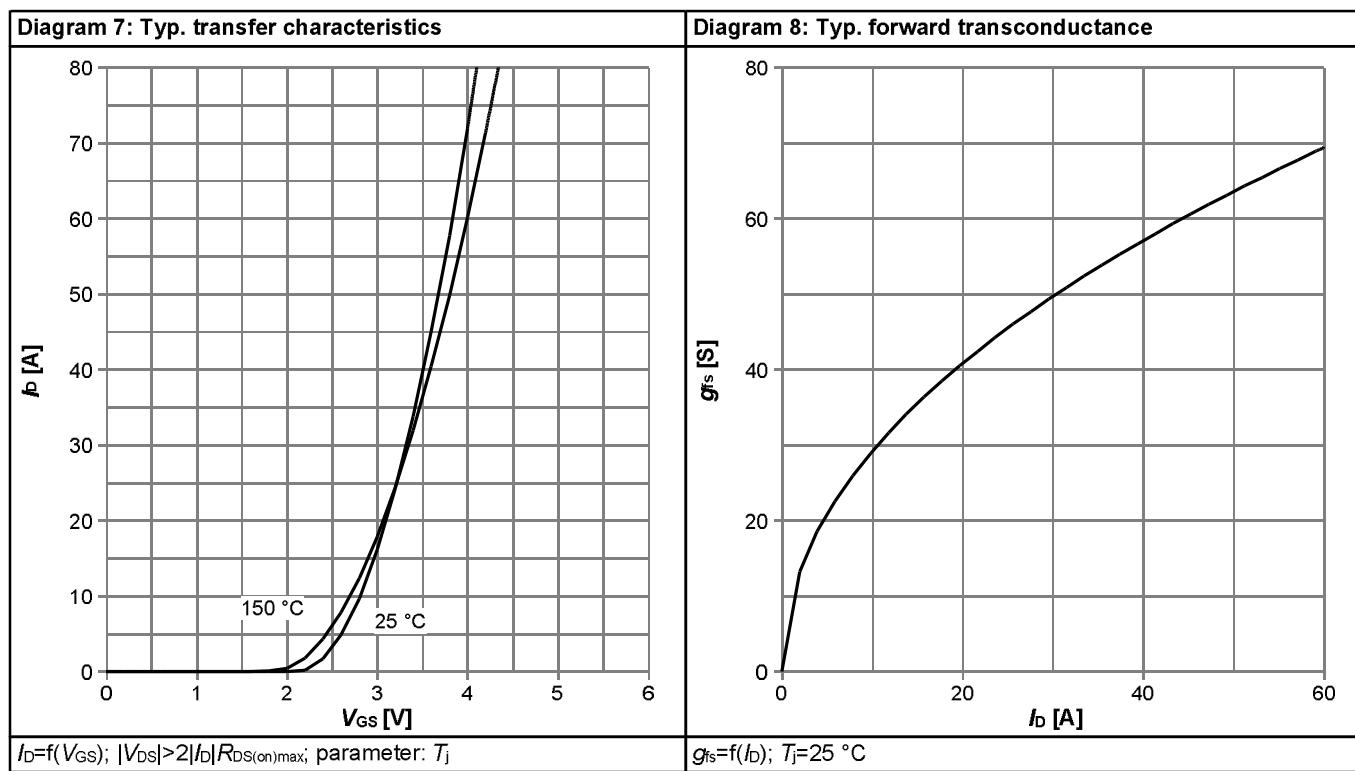
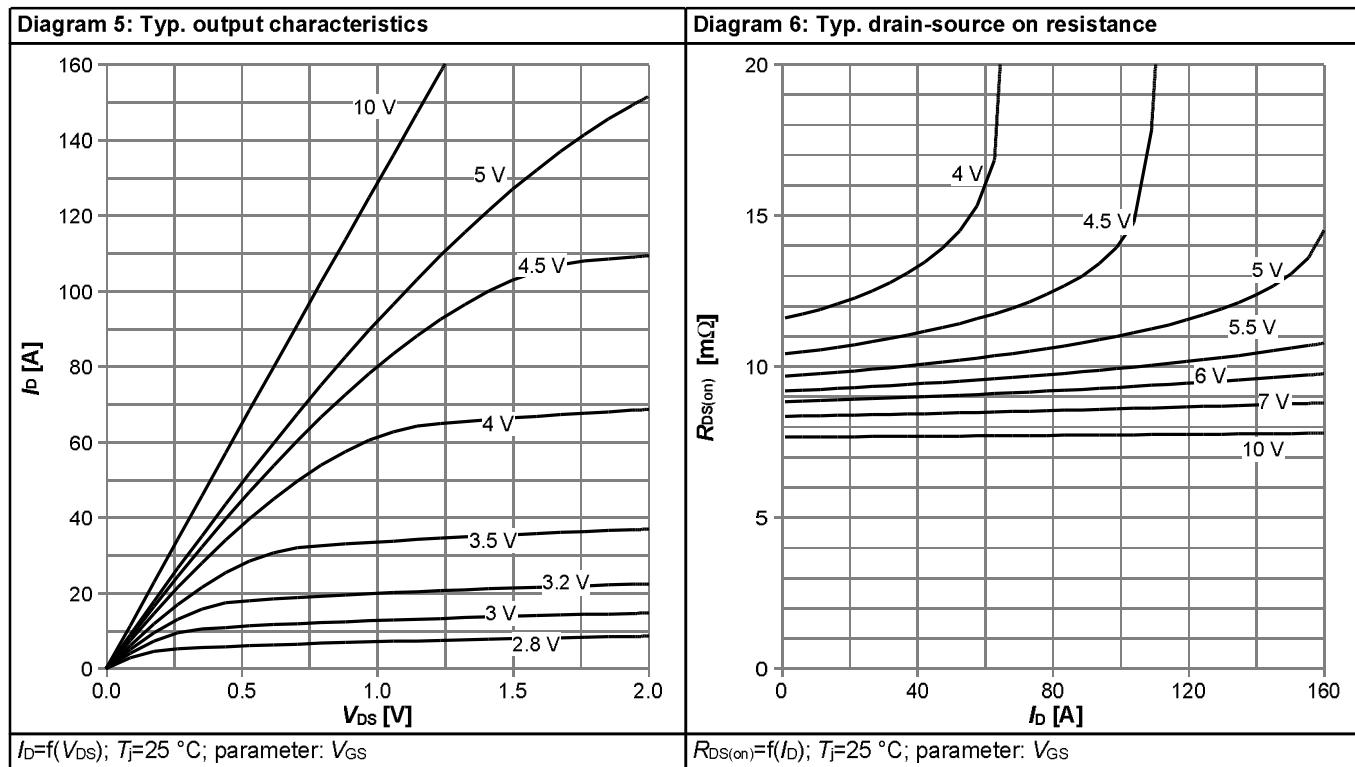
Table 7 Reverse diode

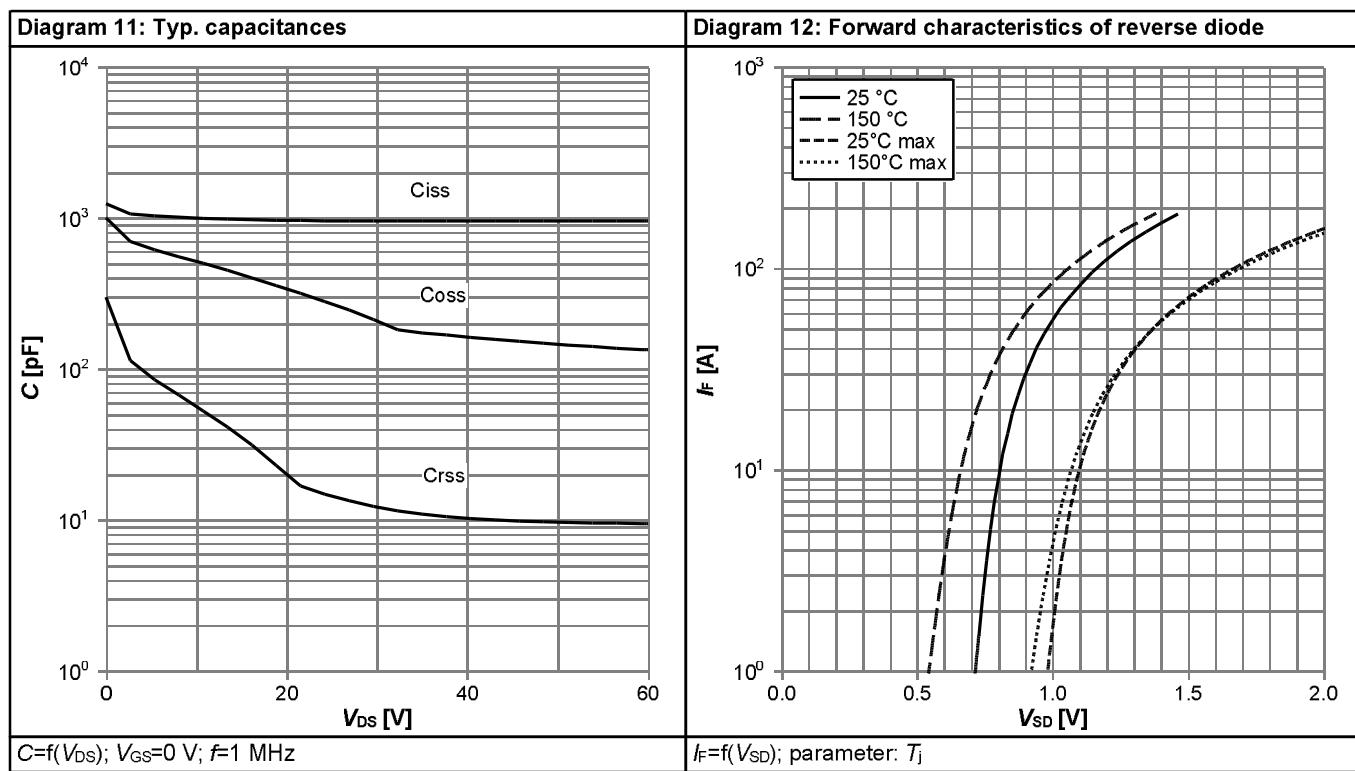
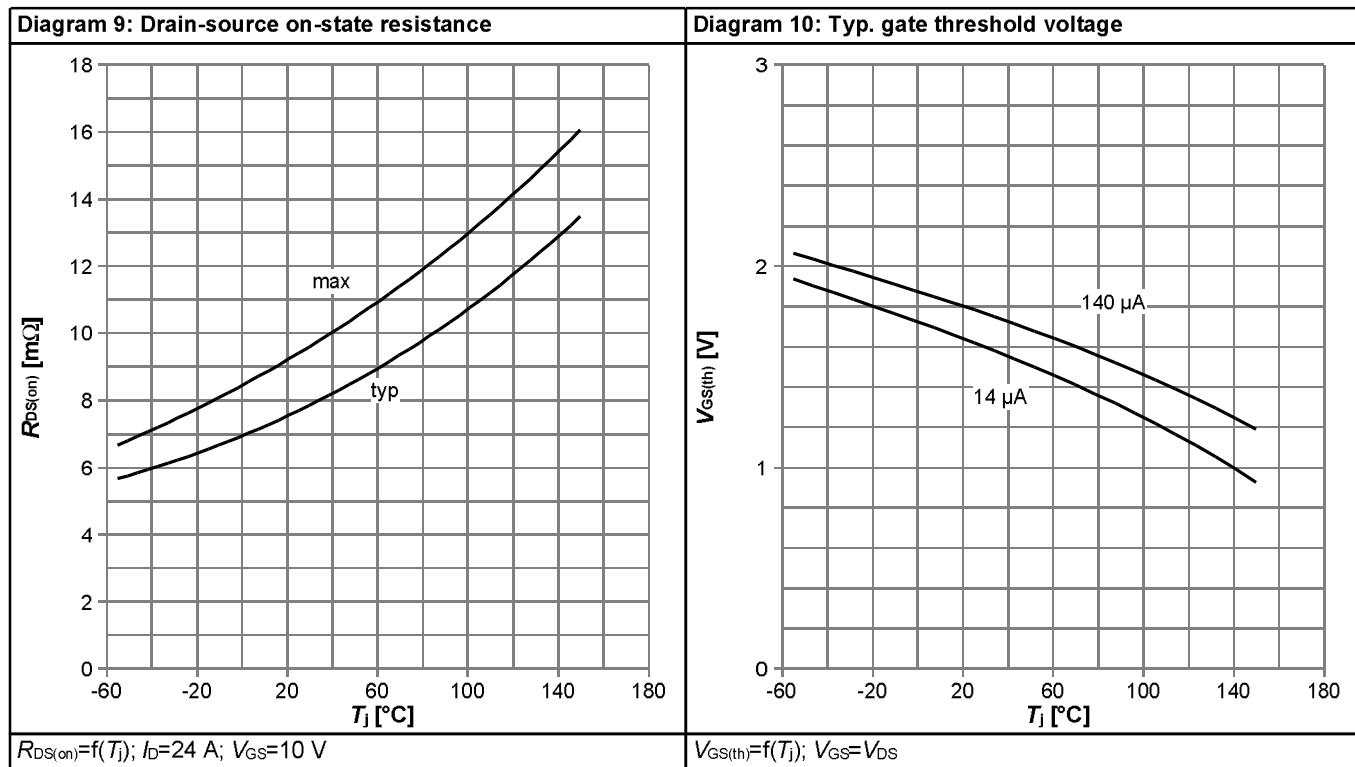
Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Diode continuous forward current	I_S	-	-	30	A	$T_C=25\text{ }^\circ\text{C}$
Diode pulse current	$I_{S,pulse}$	-	-	188	A	$T_C=25\text{ }^\circ\text{C}$
Diode forward voltage	V_{SD}	-	0.9	1.2	V	$V_{GS}=0\text{ V}$, $I_F=24\text{ A}$, $T_j=25\text{ }^\circ\text{C}$
Reverse recovery time ¹⁾	t_{rr}	-	18	36	ns	$V_R=30\text{ V}$, $I_F=24\text{ A}$, $dI/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge ¹⁾	Q_{rr}	-	6	12	nC	$V_R=30\text{ V}$, $I_F=24\text{ A}$, $dI/dt=100\text{ A}/\mu\text{s}$

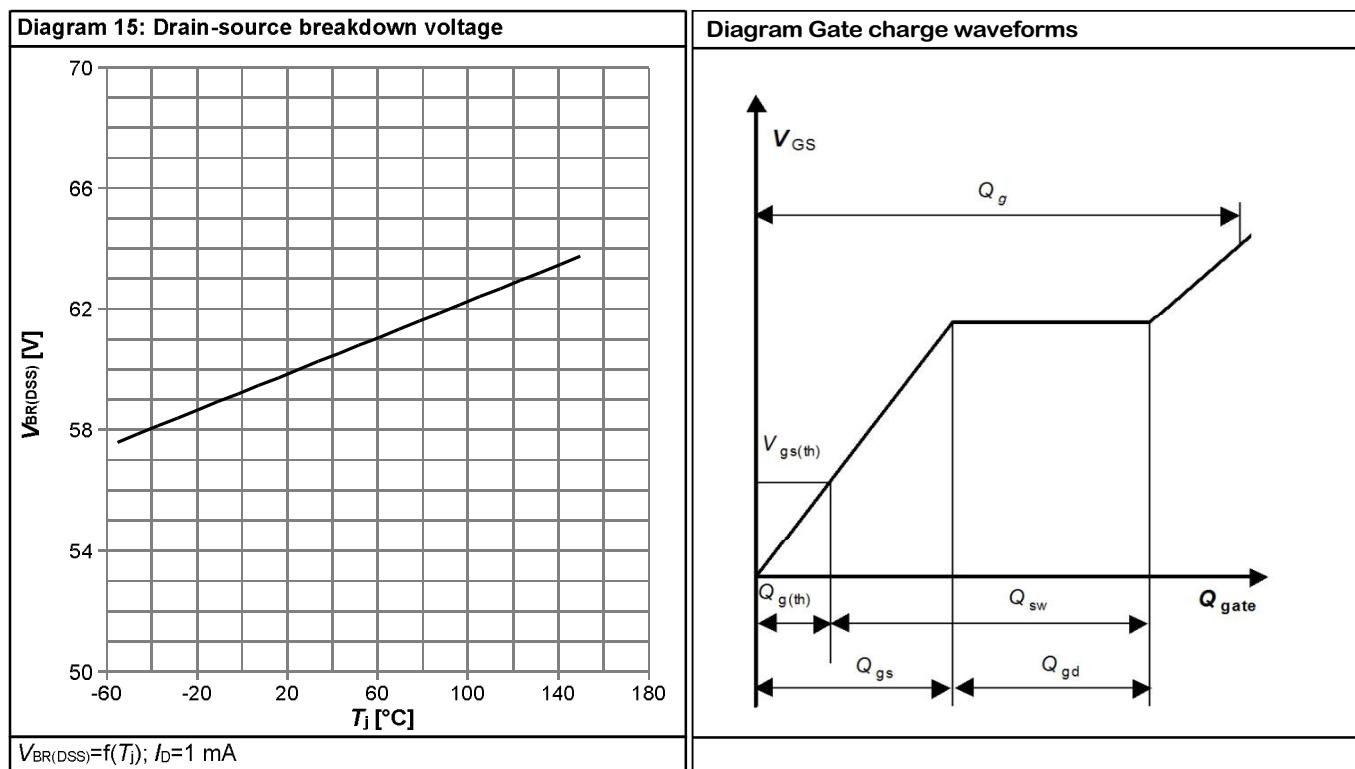
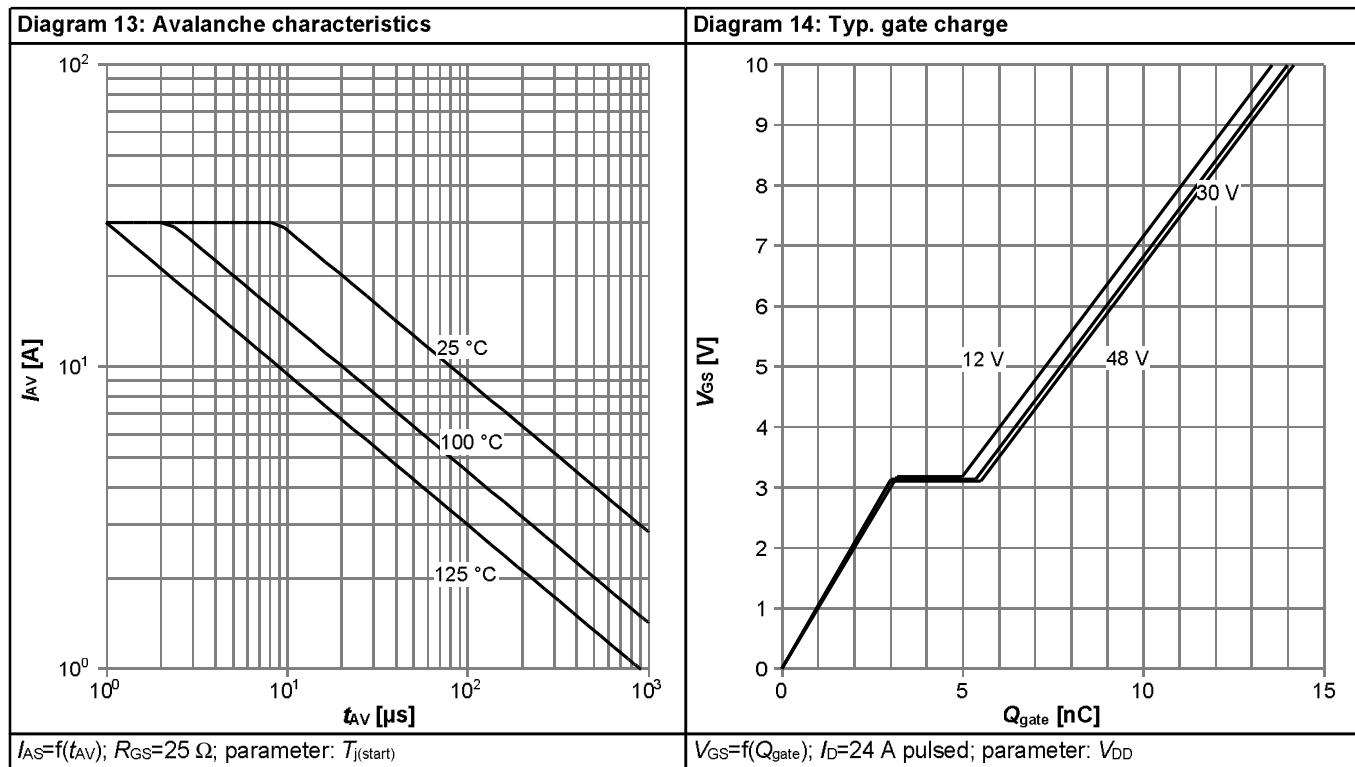
¹⁾ Defined by design. Not subject to production test.

4 Electrical characteristics diagrams

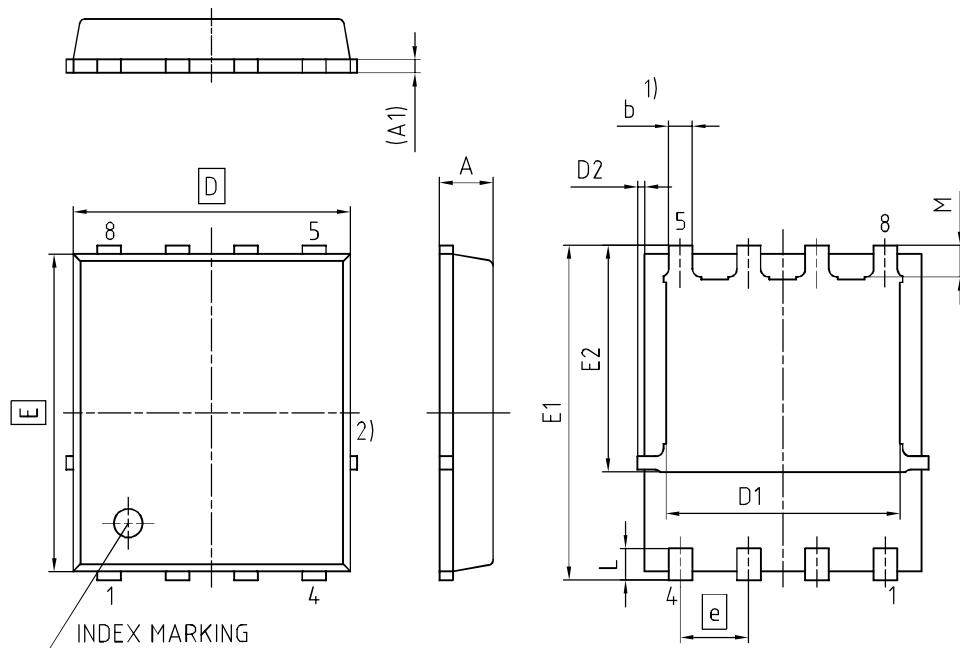








5 Package Outlines



1) EXCLUDING MOLD FLASH
 2) REMOVAL ON MOLD GATE
 INTRUSION 0.1 MM
 PROTRUSION 0.1 MM
 LEAD LENGTH UP TO ANTI FLASH LINE
 ALL METAL SURFACES ARE PLATED, EXCEPT AREA OF CUT

DIMENSION	MILLIMETERS	
	MIN.	MAX.
A	0.90	1.20
A1	0.15	0.35
b	0.34	0.54
D	4.80	5.35
D1	3.90	4.40
D2	0.03	0.23
E	5.70	6.10
E1	5.90	6.42
E2	3.88	4.31
e	1.27	
L	0.45	0.71
M	0.45	0.69

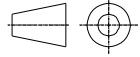
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EUROPEAN PROJECTION

ISSUE DATE
06.06.2019

Figure 1 Outline PG-TDSON-8, dimensions in mm

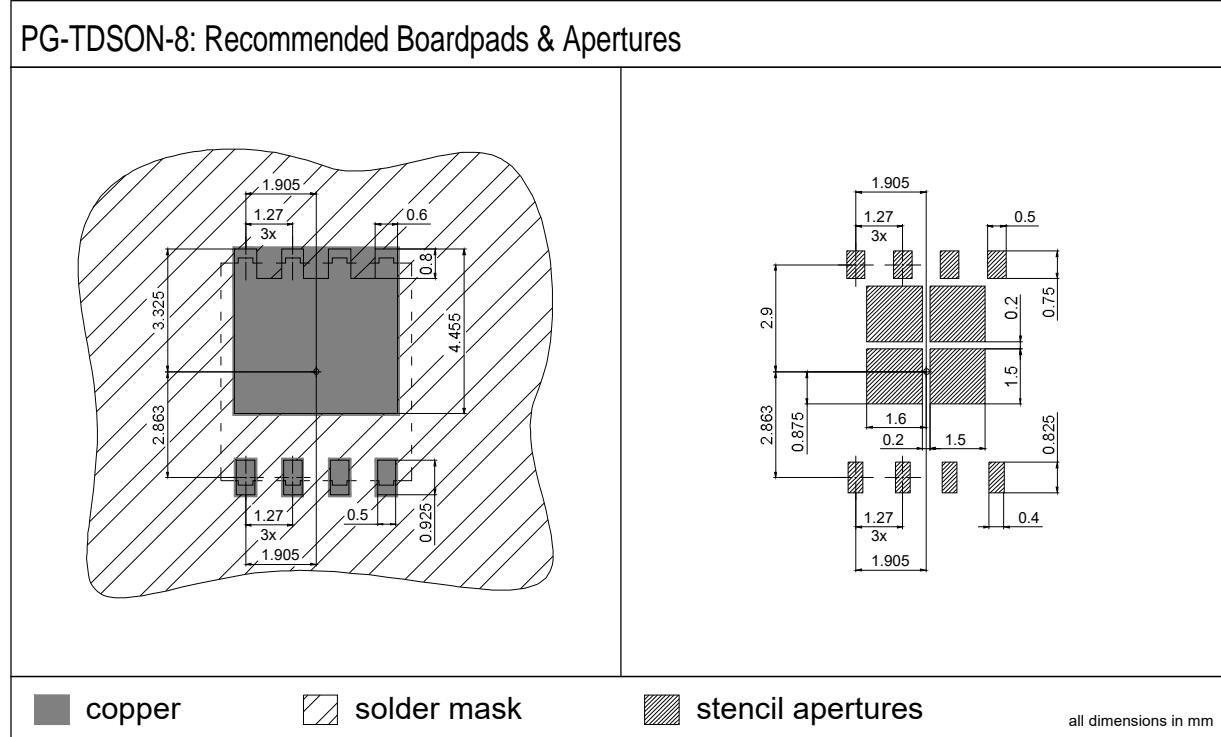
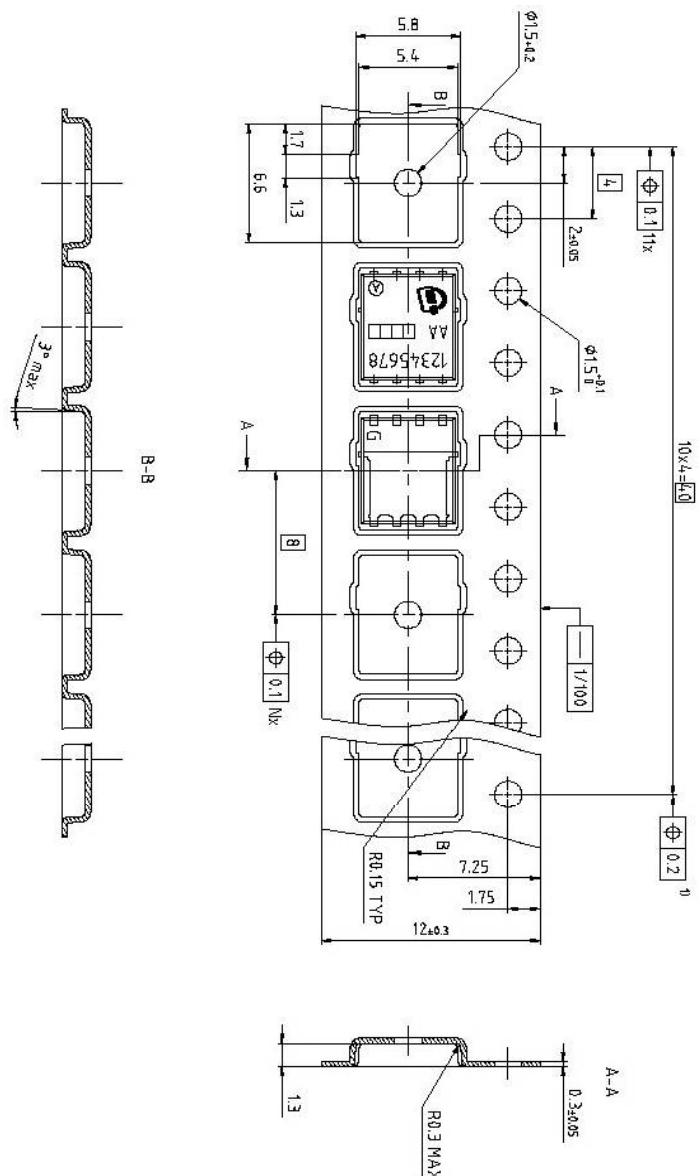


Figure 2 Outline Boardpads (TDSO-8), dimensions in mm



Dimension in mm

Figure 3 Outline Tape (TDS0N-8)

Revision History

BSC094N06LS5

Revision: 2023-01-13, Rev. 2.2

Previous Revision

Revision	Date	Subjects (major changes since last revision)
2.0	2016-09-23	Release of final version
2.1	2020-05-15	Update package drawings
2.2	2023-01-13	Update Marking

Trademarks

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